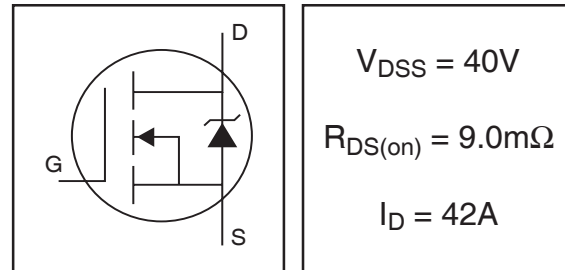


**IRFR3504ZPbF**  
**IRFU3504ZPbF**

HEXFET® Power MOSFET

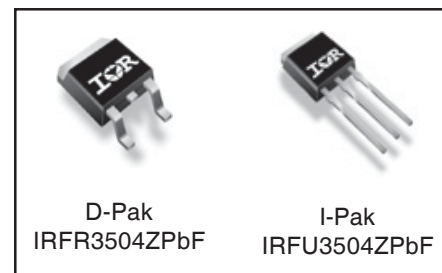
**Features**

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free



**Description**

This HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in a wide variety of applications.



**Absolute Maximum Ratings**

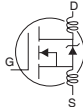
|   | Parameter   | Max.                     | Units |
|---|---|--------------------------|-------|
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) | 77                       | A     |
| I <sub>D</sub> @ T <sub>C</sub> = 100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V                   | 54                       |       |
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited) | 42                       |       |
| I <sub>DM</sub>                         | Pulsed Drain Current ①  | 310                      |       |
| P <sub>D</sub> @ T <sub>C</sub> = 25°C  | Power Dissipation   | 90                       | W     |
|   | Linear Derating Factor  | 0.60                     | W/°C  |
| V <sub>GS</sub>                         | Gate-to-Source Voltage  | ± 20                     | V     |
| E <sub>AS</sub> (Thermally limited)     | Single Pulse Avalanche Energy②                                    | 77                       | mJ    |
| E <sub>AS</sub> (Tested )               | Single Pulse Avalanche Energy Tested Value ③                      | 110                      |       |
| I <sub>AR</sub>                         | Avalanche Current ④   | See Fig.12a, 12b, 15, 16 | A     |
| E <sub>AR</sub>                         | Repetitive Avalanche Energy ⑤                                     |                          | mJ    |
| T <sub>J</sub>                          | Operating Junction and  | -55 to + 175             | °C    |
| T <sub>STG</sub>                        | Storage Temperature Range   |                          |       |
|   | Soldering Temperature, for 10 seconds                             | 300 (1.6mm from case )   |       |
|   | Mounting Torque, 6-32 or M3 screw                                 | 10 lbf•in (1.1N•m)       |       |

**Thermal Resistance**

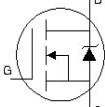
|                  | Parameter                         | Typ. | Max. | Units |
|------------------|-----------------------------------|------|------|-------|
| R <sub>θJC</sub> | Junction-to-Case                  | —    | 1.66 | °C/W  |
| R <sub>θJA</sub> | Junction-to-Ambient (PCB mount) ⑥ | —    | 40   |       |
| R <sub>θJA</sub> | Junction-to-Ambient               | —    | 110  |       |

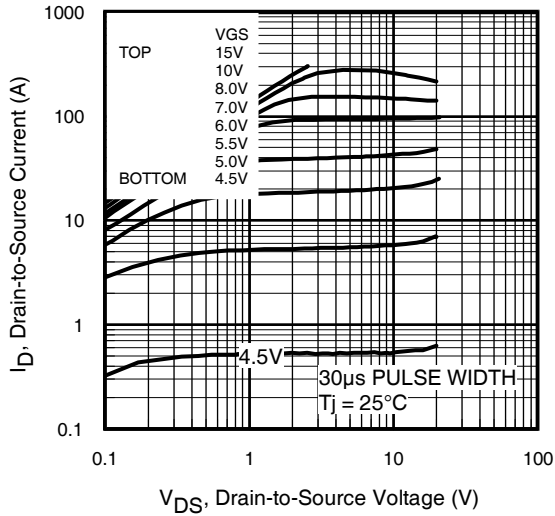
HEXFET® is a registered trademark of International Rectifier.

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

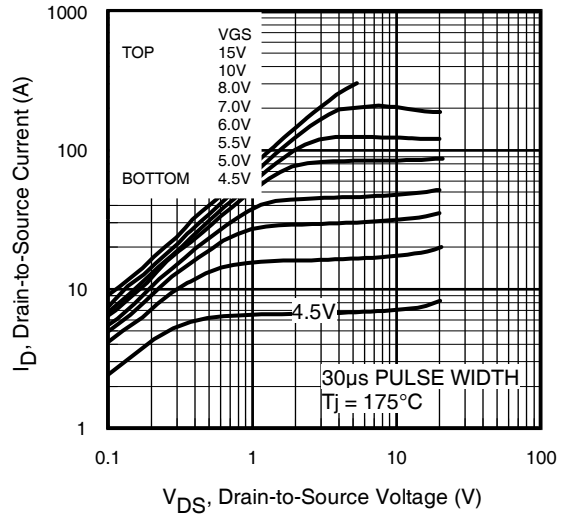
|                                | Parameter                            | Min. | Typ.  | Max. | Units      | Conditions  |
|--------------------------------|--------------------------------------|------|-------|------|------------|---|
| $V_{(BR)DS}$                   | Drain-to-Source Breakdown Voltage    | 40   | —     | —    | V          | $V_{GS} = 0V, I_D = 250\mu A$   |
| $\Delta V_{(BR)DS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.032 | —    | V/°C       | Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$                                  |
| $R_{DS(on)}$                   | Static Drain-to-Source On-Resistance | —    | 8.23  | 9.0  | m $\Omega$ | $V_{GS} = 10V, I_D = 42A$ ③   |
| $V_{GS(th)}$                   | Gate Threshold Voltage               | 2.0  | —     | 4.0  | V          | $V_{DS} = V_{GS}, I_D = 250\mu A$   |
| gfs                            | Forward Transconductance             | 32   | —     | —    | S          | $V_{DS} = 10V, I_D = 42A$   |
| $I_{DSS}$                      | Drain-to-Source Leakage Current      | —    | —     | 20   | $\mu A$    | $V_{DS} = 40V, V_{GS} = 0V$   |
|                                |                                      | —    | —     | 250  |            | $V_{DS} = 40V, V_{GS} = 0V, T_J = 125^\circ\text{C}$                                  |
| $I_{GSS}$                      | Gate-to-Source Forward Leakage       | —    | —     | 200  | nA         | $V_{GS} = 20V$  |
|                                | Gate-to-Source Reverse Leakage       | —    | —     | -200 |            | $V_{GS} = -20V$   |
| $Q_g$                          | Total Gate Charge                    | —    | 30    | 45   | nC         | $I_D = 42A$   |
| $Q_{gs}$                       | Gate-to-Source Charge                | —    | 9.6   | —    |            | $V_{DS} = 32V$  |
| $Q_{gd}$                       | Gate-to-Drain ("Miller") Charge      | —    | 12    | —    |            | $V_{GS} = 10V$ ③  |
| $t_{d(on)}$                    | Turn-On Delay Time                   | —    | 15    | —    | ns         | $V_{DD} = 20V$  |
| $t_r$                          | Rise Time                            | —    | 74    | —    |            | $I_D = 42A$   |
| $t_{d(off)}$                   | Turn-Off Delay Time                  | —    | 30    | —    |            | $R_G = 15\ \Omega$  |
| $t_f$                          | Fall Time                            | —    | 38    | —    |            | $V_{GS} = 10V$ ③  |
| $L_D$                          | Internal Drain Inductance            | —    | 4.5   | —    | nH         | Between lead,<br>6mm (0.25in.)<br>from package<br>and center of die contact           |
| $L_S$                          | Internal Source Inductance           | —    | 7.5   | —    |            |  |
| $C_{iss}$                      | Input Capacitance                    | —    | 1510  | —    | pF         | $V_{GS} = 0V$   |
| $C_{oss}$                      | Output Capacitance                   | —    | 340   | —    |            | $V_{DS} = 25V$  |
| $C_{rss}$                      | Reverse Transfer Capacitance         | —    | 190   | —    |            | $f = 1.0\text{MHz}$   |
| $C_{oss}$                      | Output Capacitance                   | —    | 1100  | —    |            | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$                                       |
| $C_{oss}$                      | Output Capacitance                   | —    | 340   | —    |            | $V_{GS} = 0V, V_{DS} = 32V, f = 1.0\text{MHz}$  |
| $C_{oss\ eff.}$                | Effective Output Capacitance         | —    | 460   | —    |            | $V_{GS} = 0V, V_{DS} = 0V\ \text{to}\ 32V$ ④  |

## Source-Drain Ratings and Characteristics

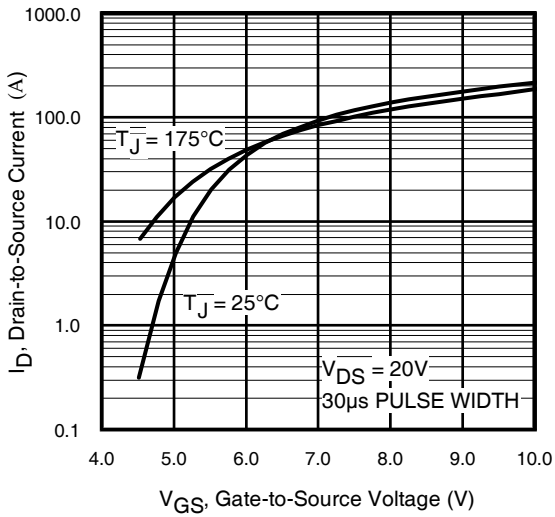
|          | Parameter                                 | Min.  | Typ. | Max. | Units | Conditions  |
|----------|---|---|------|------|-------|---|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —   | —    | 42   | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode.               |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode) ①   | —   | —    | 310  |       |  |
| $V_{SD}$ | Diode Forward Voltage                     | —   | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 42A, V_{GS} = 0V$ ③                                    |
| $t_{rr}$ | Reverse Recovery Time                     | —   | 18   | 27   | ns    | $T_J = 25^\circ\text{C}, I_F = 42A, V_{DD} = 20V$                                     |
| $Q_{rr}$ | Reverse Recovery Charge                   | —   | 9.2  | 14   | nC    | $di/dt = 100A/\mu s$ ③  |
| $t_{on}$ | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ ) |      |      |       |   |



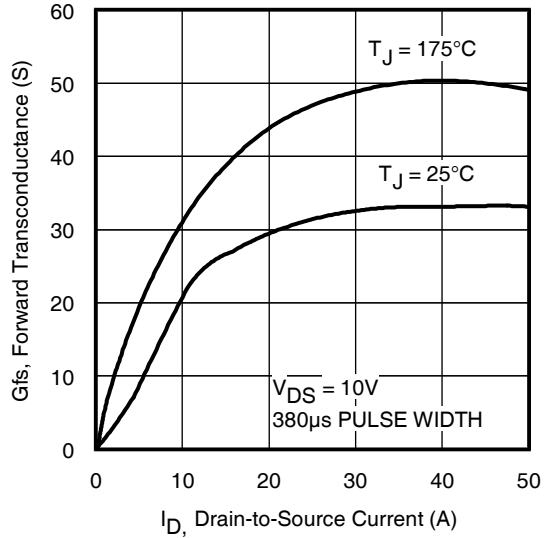
**Fig 1.** Typical Output Characteristics



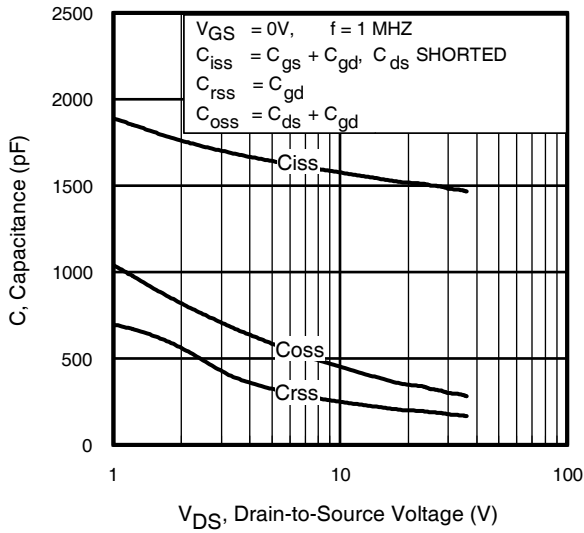
**Fig 2.** Typical Output Characteristics



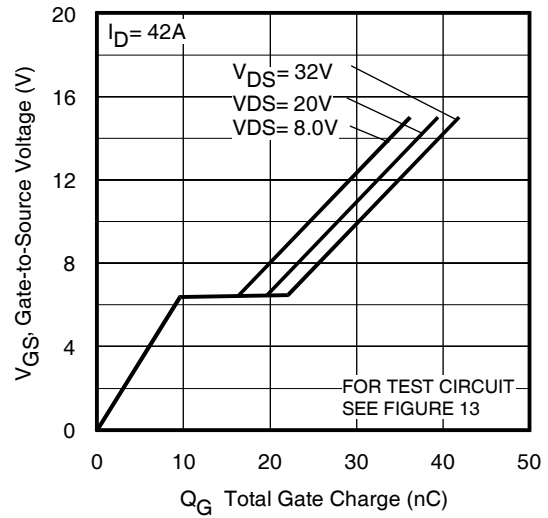
**Fig 3.** Typical Transfer Characteristics



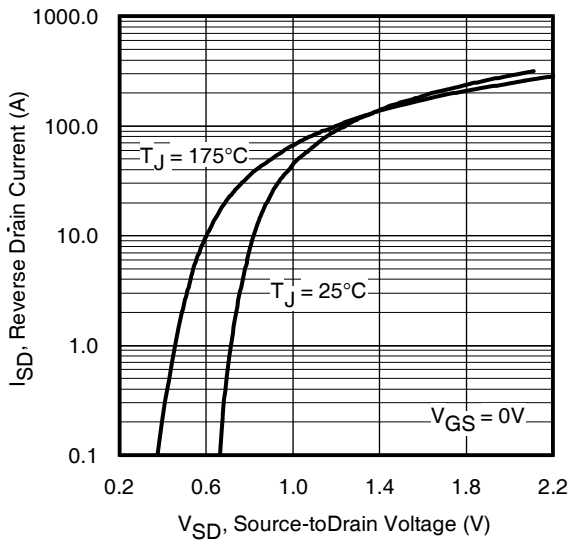
**Fig 4.** Typical Forward Transconductance Vs. Drain Current



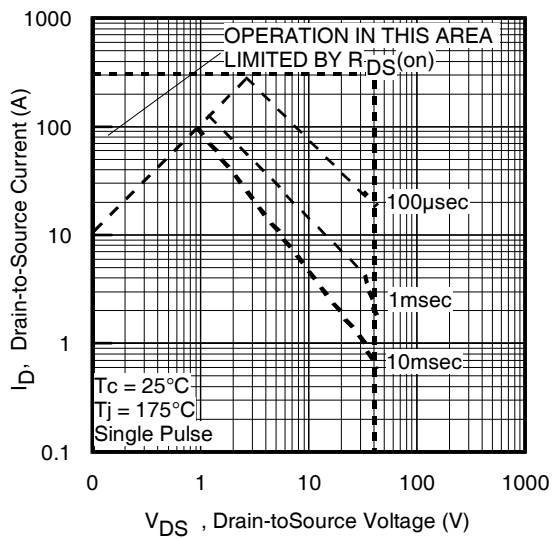
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 8.** Maximum Safe Operating Area

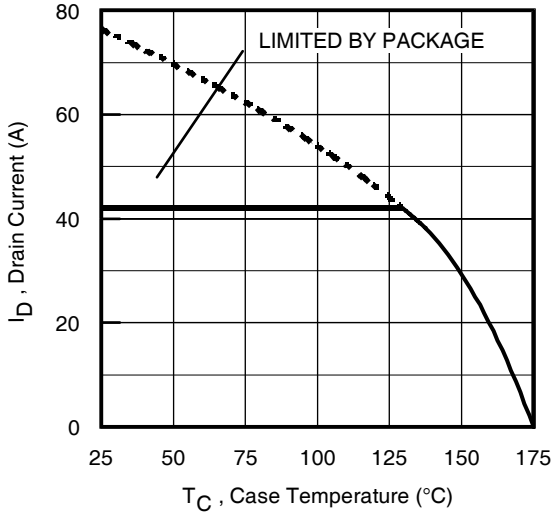


Fig 9. Maximum Drain Current Vs. Case Temperature

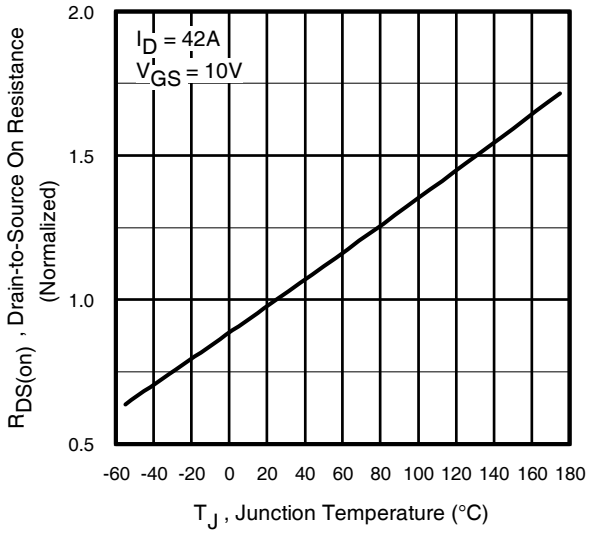


Fig 10. Normalized On-Resistance Vs. Temperature

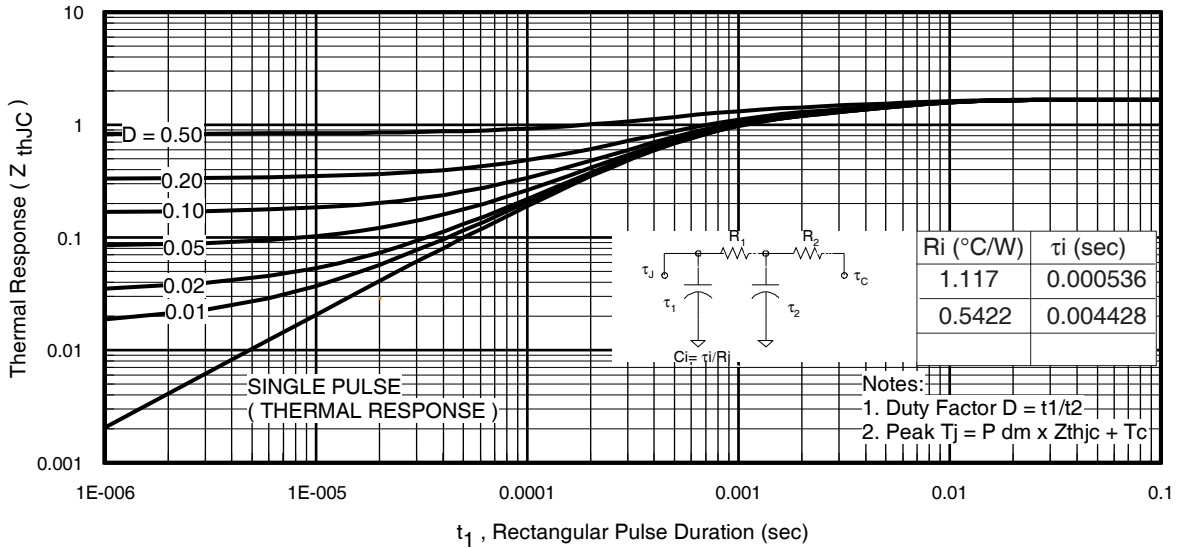


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRFR/U3504ZPbF

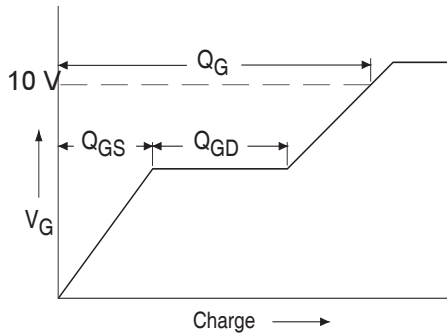
International  
**IR** Rectifier



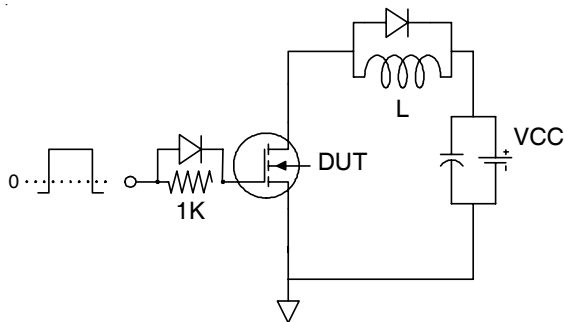
**Fig 12a.** Unclamped Inductive Test Circuit



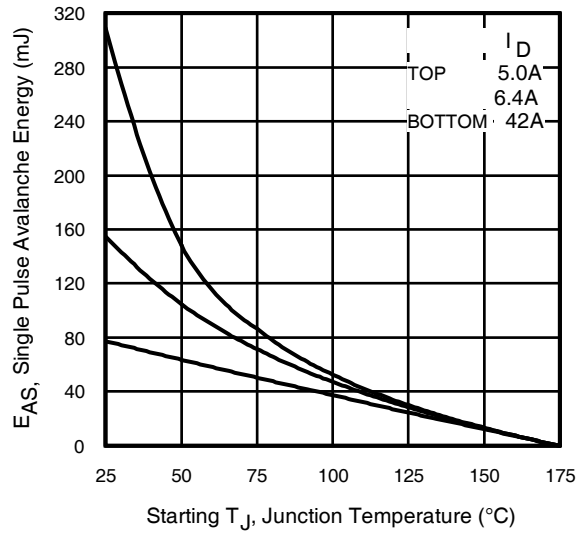
**Fig 12b.** Unclamped Inductive Waveforms



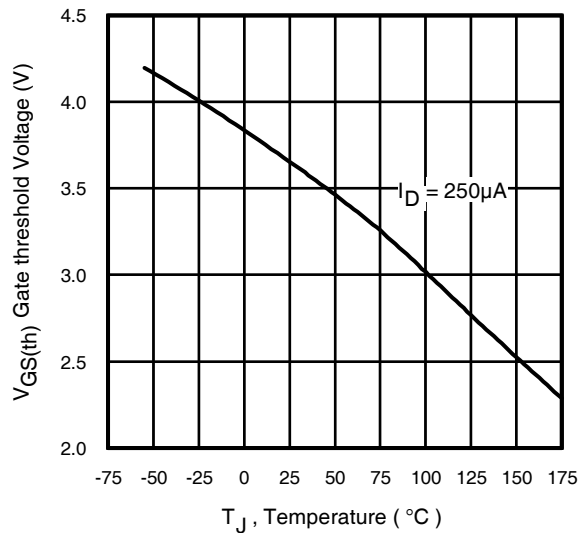
**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 14.** Threshold Voltage Vs. Temperature

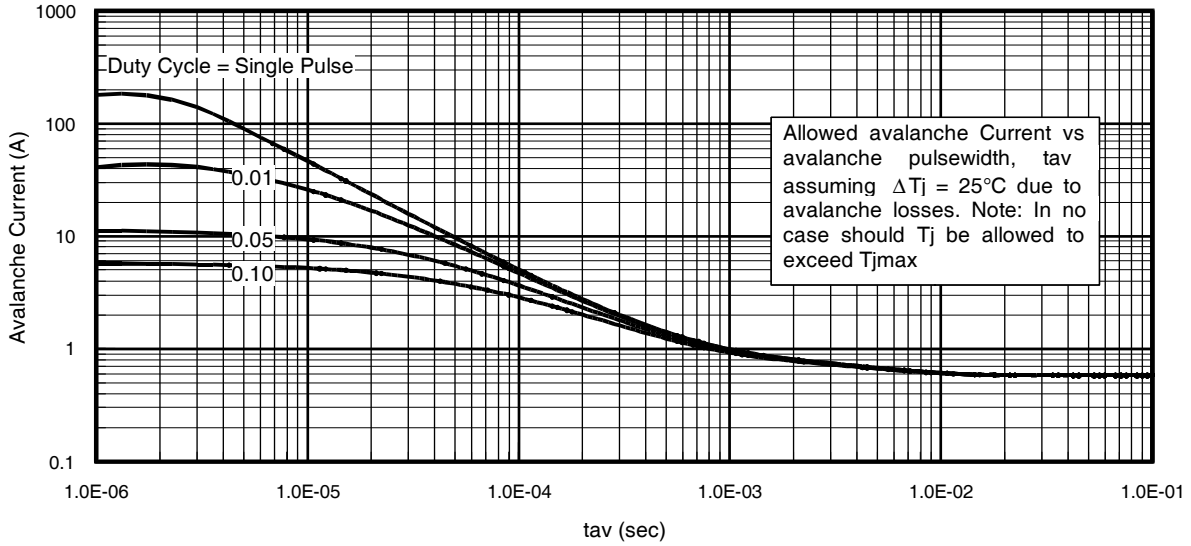


Fig 15. Typical Avalanche Current Vs. Pulsewidth

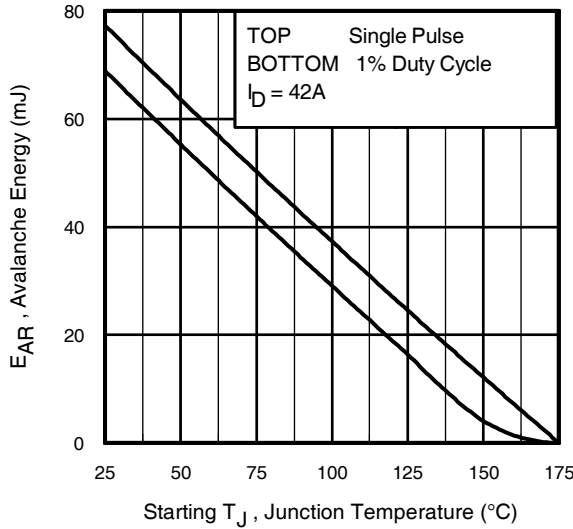


Fig 16. Maximum Avalanche Energy Vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 15, 16:**  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$$

$$I_{av} = 2 \Delta T / [ 1.3 \cdot BV \cdot Z_{th} ]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$



**Fig 17. Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs**



**Fig 18a. Switching Time Test Circuit**

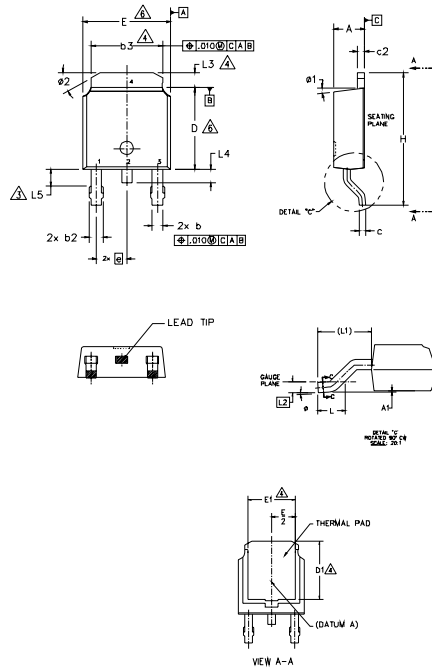


**Fig 18b. Switching Time Waveforms**



## D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)



**NOTES:**

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- △ LEAD DIMENSION UNCONTROLLED IN L5.
- △ DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- △ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- △ DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- △ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

| SYMBOL | DIMENSIONS  |       |           |      | NOTES |
|--------|-------------|-------|-----------|------|-------|
|        | MILLIMETERS |       | INCHES    |      |       |
|        | MIN.        | MAX.  | MIN.      | MAX. |       |
| A      | 2.18        | 2.39  | .086      | .094 |       |
| A1     | -           | 0.13  | -         | .005 |       |
| b      | 0.64        | 0.89  | .025      | .035 |       |
| b1     | 0.65        | 0.79  | .025      | .031 | 7     |
| b2     | 0.76        | 1.14  | .030      | .045 |       |
| b3     | 4.95        | 5.46  | .195      | .215 | 4     |
| c      | 0.46        | 0.61  | .018      | .024 |       |
| c1     | 0.41        | 0.56  | .016      | .022 | 7     |
| c2     | 0.46        | 0.89  | .018      | .035 |       |
| D      | 5.97        | 6.22  | .235      | .245 | 6     |
| D1     | 5.21        | -     | .205      | -    | 4     |
| E      | 6.35        | 6.73  | .250      | .265 | 6     |
| E1     | 4.32        | -     | .170      | -    | 4     |
| e      | 2.29 BSC    |       | .090 BSC  |      |       |
| H      | 9.40        | 10.41 | .370      | .410 |       |
| L      | 1.40        | 1.78  | .055      | .070 |       |
| L1     | 2.74 BSC    |       | .108 REF. |      |       |
| L2     | 0.51 BSC    |       | .020 BSC  |      |       |
| L3     | 0.89        | 1.27  | .035      | .050 | 4     |
| L4     | -           | 1.02  | -         | .040 |       |
| L5     | 1.14        | 1.52  | .045      | .060 | 3     |
| Ø      | 0"          | 10"   | 0"        | 10"  |       |
| Ø1     | 0"          | 15"   | 0"        | 15"  |       |
| Ø2     | 25"         | 35"   | 25"       | 35"  |       |

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

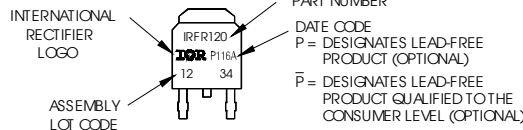
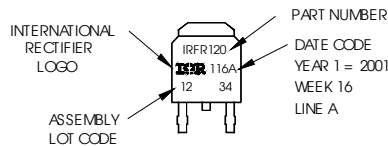
- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

## D-Pak (TO-252AA) Part Marking Information

EXAMPLE: THIS IS AN IRFR120 WITH ASSEMBLY LOT CODE 1234 ASSEMBLED ON VW16, 2001 IN THE ASSEMBLY LINE "A"

Note: "P" in assembly line position indicates "Lead-Free"

"P" in assembly line position indicates "Lead-Free" qualification to the consumer-level



YEAR 1 = 2001  
WEEK 16  
A = ASSEMBLY SITE CODE

**Notes:**

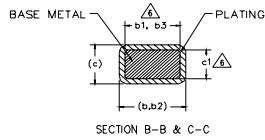
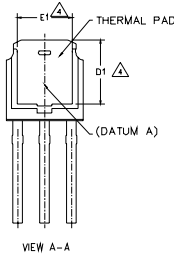
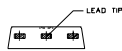
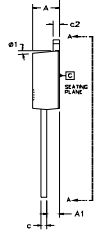
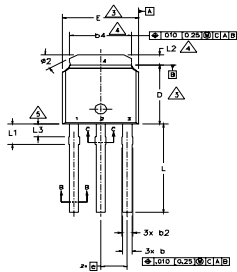
1. For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/aut/>
2. For the most current drawing please refer to IR website at <http://www.irf.com/package/>

# IRFR/U3504ZPbF



## I-Pak (TO-251AA) Package Outline

Dimensions are shown in millimeters (inches)



**NOTES:**

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS]
- △ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- △- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION b4, L2, E1 & D1.
- △- LEAD DIMENSION UNCONTROLLED IN L3.
- △- DIMENSION b1, b3 & c1 APPLY TO BASE METAL ONLY.
- 7.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA (Date 06/02).
- 8.- CONTROLLING DIMENSION : INCHES.

| SYMBOL | DIMENSIONS  |      |          |      | NOTES |
|--------|-------------|------|----------|------|-------|
|        | MILLIMETERS |      | INCHES   |      |       |
|        | MIN.        | MAX. | MIN.     | MAX. |       |
| A      | 2.18        | 2.39 | .086     | .094 |       |
| A1     | 0.89        | 1.14 | .035     | .045 |       |
| b      | 0.64        | 0.89 | .025     | .035 |       |
| b1     | 0.65        | 0.79 | .025     | .031 | 6     |
| b2     | 0.76        | 1.14 | .030     | .045 |       |
| b3     | 0.76        | 1.04 | .030     | .041 | 6     |
| b4     | 4.95        | 5.46 | .195     | .215 | 4     |
| c      | 0.46        | 0.61 | .018     | .024 |       |
| c1     | 0.41        | 0.56 | .016     | .022 | 6     |
| c2     | 0.46        | 0.89 | .018     | .035 |       |
| D      | 5.97        | 6.22 | .235     | .245 | 3     |
| D1     | 5.21        | -    | .205     | -    | 4     |
| E      | 6.35        | 6.73 | .250     | .265 | 3     |
| E1     | 4.32        | -    | .170     | -    | 4     |
| e      | 2.29 BSC    |      | .090 BSC |      |       |
| L      | 8.89        | 9.65 | .350     | .380 |       |
| L1     | 1.91        | 2.29 | .045     | .090 |       |
| L2     | 0.89        | 1.27 | .035     | .050 | 4     |
| L3     | 1.14        | 1.52 | .045     | .060 | 5     |
| ø1     | 0"          | 15"  | 0"       | 15"  |       |
| ø2     | 25"         | 35"  | 25"      | 35"  |       |

**LEAD ASSIGNMENTS**

**HEXFET**

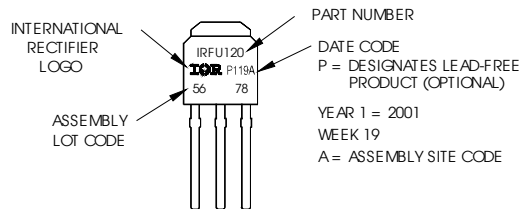
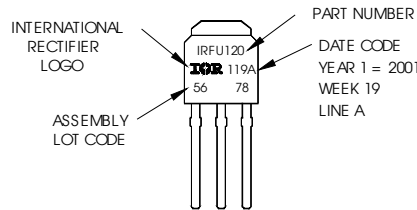
- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

## I-Pak (TO-251AA) Part Marking Information

EXAMPLE: THIS IS AN IRFU120 WITH ASSEMBLY LOT CODE 5678 ASSEMBLED ON WW19, 2001 IN THE ASSEMBLY LINE "A"

Note: "P" in assembly line position indicates Lead-Free!

OR

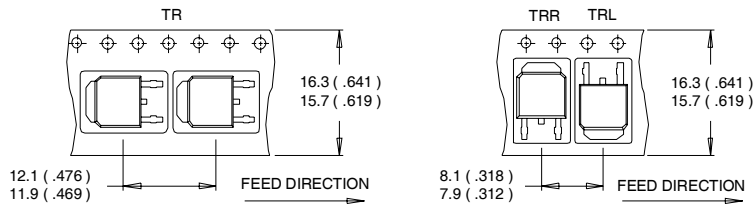


**Notes:**

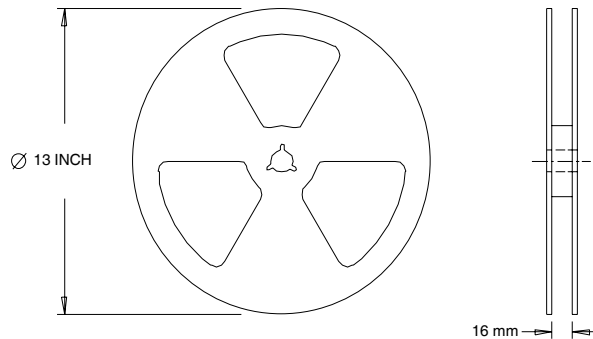
1. For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/autol/>
2. For the most current drawing please refer to IR website at <http://www.irf.com/package/>

## D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
  2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
  3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES :
1. OUTLINE CONFORMS TO EIA-481.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by  $T_{Jmax}$ ; starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.09\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 42\text{A}$ ,  $V_{GS} = 10\text{V}$ . Part not recommended for use above this value.
- ③ Pulse width  $\leq 1.0\text{ms}$ ; duty cycle  $\leq 2\%$ .
- ④  $C_{OSS}$  eff. is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to  $80\% V_{DSS}$ .
- ⑤ Limited by  $T_{Jmax}$ , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑥ This value determined from sample failure population. 100% tested to this value in production.
- ⑦ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

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